

**Notice of References Cited**Application/Control No.  
**09/661,375**Applicant(s)/Patent Under Reexam  
**Hannes Eberle et al.**Examiner  
**Talivaldis Ivars Smits**Art Unit  
**2654**

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	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	5,787,151	7/1998	Nakatsu et al.	379	88.23
B	5,913,195	7/1999	Weeren et al.	704	270
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**NON-PATENT DOCUMENTS**

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